

Power Mosfet STRH100N10 – STRH40N6 – STRH100N6 – STRH8N10 – STRHMF16N20 Component Title:

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		Executive N	Member: (CNES	3	111111 10112	.0	D	rate: 16/03/2023		303F-rev1	
Components (includ	ling series and families	s) submitted for	or Extension	of Qu	alification /	Approval:					l	1
ESCC COMPONENT NO.	VARIANTS RANGE OF COM		MPONENTS BASED ON		li.	TEST VEHICLE / S		IPONENT IMILAR				
5205/021	01, 02	TO-254/	TO-254AA STRH100N			00N1	0	ID33637009Z3				
5205/022	01, 02	TO-254/	TO-254AA STRH100N6									
5205/023	01	SMD.5	SMD.5 STRH8N10				ID33718004Z6					
5205/024	01	SMD.5				STRH4	0N6					
5205/034	01, 02	SMD.5	SMD.5 STRHMF16N2			120	ID33018001ZX					
Component M	lanufacturer		cation of Mar			. ,	3				l	4
STMicroelectronics		3, rue de	e Suisse BP4	1 199,	35041 Reni	nes Cedex	(Date	of original qualification : 14/10/2010 ficate Ref No. 303	approval:		
		5					6					7
ESCC Specifications			ons to LVT tes	sting a	and Detail S	Specification	on	Qualification Extension Report				
Maintenance of qual Generic: 5000	lification testing: Issue: 10	used:	⊠ Yes		(supply d	etails in B	ox	reference and date: STRH100N10HYG_33637009Z3_Chart F4 23/09/21				
Generic. 3000	13300.	110	м 100		15)	otalio III D	• **	STRI	H8N10SG_33718004Z6			
Detail(s): 5205/02 5205/02 5205/02 5205/02 5205/03	22 8 23 9 24 9	Deviation from current Specifications: 06/05/21 STRHMF16N20_33018001ZX_Evastress, accelerated electrical endur stress) STRHMF16N20_33018001ZX_Quarest			l endurance, te	emperature						
		No [⊠ Yes		(Supply o	details)		(300)	HMF16N20_33018001Z krad)	X_SEE and T	ID test	
0	ment or equivalent to	at requite duri	na ourront vo	didity	period in su	nnort of th	sie an	nlicatio	n (those to ESCC listed	l firet)		8
Project Name	Testing Leve	2297	LAT	inuity		Date code		piicatio		ity Delivered		
,												
PID changes since s	start of qualification		9	Cur	rent PID V	erified by:			F. Vacher, CNI	ES		10
None		-	1				N	ame of Excutive Repres	sentative			
Minor* ⊠			Ref	No: 8	3097046 (gener	ic) Rev	36 & 8212222 (specific	: Mosfet) rev 1	6		
Major* ⊠	*Provide details in bo	ox:		Issu		07/02/2023	3		Date	e:		
				110	5000-2000					08/10/2021		11
Current Manufacturii	ng facilities surveyed l	by:			-	olane, CNE		on				
Satisfactory:	Yes ⊠	No		e of E	xecutive Re	presentati	ive)			(Date)		
Report Reference:	CR-Visite Octo	bre 2021										

	APPLICAT	ION FOR EXTE	ENSION OF ESCC QUA	ALIFICATION APPROVAL	Page 2
ESCC	Component title:		t STRH100N10 – STRH - STRHMF16N20	H40N6 - STRH100N6 -	Appl. No.
	Executive Member:	CNES		Date: 15/03/2023	303F-rev1
Failure Analysis, DPA, NCCS available:	Yes	□ No)	12
Ref. No's and purposes:		-= >			
The undersigned hereby certifies on behalf that the appropriate documentation has bee (except as stated in box 15;) - that the repo CNES as the responsible Executive Membro	en evaluated; - that ful erts and data are availa	II compliance to able at the ESC	all ESCC requirements CC Executive and therefore	s is evidence fore applies on behalf of	endul Ar
Date: 16/03/2023				G.QUADRI	
				(Signature of the Executive	Coordinator)
Continuation of Boxes above:					14
Box 1 : Rev.1 of application 303 F allows to include	the variants 01 and 0	02 referring to the	he detailed specification	n ESCC 5205/034	
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Power Mosfet STRH100N10 – STRH40N6 – STRH100N6 – STRH8N10 – STRHMF16N20

Executive Member: CNES

Component title:

Date: 15/03/2023

B. Schade: Head of the Product Assurance and Safety Department

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				15
Non com	pliance to ESCC requirements:			
No.:	Specification	Paragraph	Non compliance	
		-		
Additiona	I tasks required to achieve full compliance for	ESCC qualification or rationale for acceptability of		16
noncomp	liance:			
Executive	Manager Disposition			17
Applicatio	on Approval: Yes 🗵 No 🗆			
Action / F				
			3.81	
			5.821	
Date:				



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ANNEX 1: LIST OF TESTS DONE TO SUPPORT EXTENSION OF QUALIFICATION

Tests conducted in compliance with:

ESCC 5000 generic specification; Chart F4 (for ESCC/QPL parts); or PID-TFD (for ESCC/QML parts)

Tests vehicle identification/description:

STRH100N10HYG_33637009Z3_DC2044 Full Chart F4	STRHMF16N20_33018001ZX_DC2037 Full chart F4
STRH8N10SG_33718004Z6_DC2131 Full Chart F4	

Detail Specification reference:

Chart F4	Test	Tick when done	Conditions	Date Code Diffusion Lot	Tested Qty	N° of Rejects	Comments if not performed. Comments on Rejection
	Mechanical shock	⊠	MIL-STD-750 TM2016	2044 2131 2037	15 +15 +15	0	
	Vibration	×	MIL-STD-750 TM2056	2044 2131 2037	15 +15 +15	0	
	Constant acceleration	⊠	MIL-STD-750 TM2006	2044 2131 2037	15 +15 +15	0	
dno	Seal Fine leak Gross leak	⊠	MIL-STD-750 TM1071	2044 2131 2037	15 +15 +15	0	
al Subgr	Electrical Measurement	⋈	Intermediate and End- Point Electrical Measurements	2044 2131 2037	15 +15 +15	0	
nanica	External Visual	×	ESCC Basic Spec 20500	2044 2131 2037	15 +15 +15	0	
Environmental/Mechanical Subgroup	Thermal shock		MIL-STD-750 TM1056	Click here to enter text.			Only applicable to axial lead glass diodes
neur	Temperature Cycling	⊠	MIL-STD-750 TM1051	2044 2131 2037	15 +15 +15	0	
nviro	Moisture Resistance	⊠	MIL-STD-750 TM1021	2044 2131 2037	15 +15 +15	0	
ū	Seal Fine leak Gross leak	×	MIL-STD-750 TM1071	2044 2131 2037	15 +15 +15	0	
	Electrical Measurement	×	Intermediate and End- Point Electrical Measurements	2044 2131 2037	15 +15 +15	0	
	External Visual	×	ESCC Basic Spec 20500	2044 2131 2037	15 +15 +15	0	
dn	Operating Life		ESCC 5000 Para. 8.19	2044 2131 2037	15 +15 +15	0	
Subgro	Electrical Measurement	×	Intermediate and End- Point Electrical Measurements	2044 2131 2037	15 +15 +15	0	
Endurance Subgroup	Seal Fine leak Gross leak	×	MIL-STD-750 TM1071	2044 2131 2037	15 +15 +15	0	
Ē	External Visual Inspection	⊠	ESCC Basic Spec 20500	2044 2131 2037	15 +15 +15	0	
4	Permanence of Marking		ESCC Basic Spec 24800				Not applicable on Laser marking
Assembly Capability Subgroup	Terminal Strength		ESCC 5000 Para. 8.18	2044 2131 2037	5 + 5 +5	0	
	Internal Visual		ESCC Basic Spec 20400	2044 2131 2037	5 + 5 +5	0	
semb	Bond Strength	⊠	MIL-STD-750 TM 2037	2044 2131 2037	3+3+3	0	
As	Die Shear		MIL-STD-750 TM 2017	2044 2131 2037	3+3+3	0	



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Ch art F4	Test	Tick when done	Conditions	Date Code Diffusion Lot	Tested Qty	N° of Rejects	Comments if not performed. Comments on Rejection
<u>a</u>							
Additional							
Ad							



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Executive Member: CNES Date: 15/03/2023

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NOTES ON THE COMPLETION OF THE APPLICATION FORM FOR ESCC QUALIFICATION EXTENSION APPROVAL

ENTRIES Form heading	shall indicate: - the title of the component as given in its detail specification or the name of the series, family; - the Executive Member; - the entering date; - the certificate number and its sequential suffix.
Box 1	shall provide details given in the table; in particular there shall be listed: - the variants or range of variants; - the range of components (the ESCC code is recommended to indicate the values or values range, the tolerance, the voltage, etc); the designation given in the detail specification as 'base on'; - under Test Vehicle enter either an ESCC code or the specific characteristic capable of identifying the component tested (e.g., voltage of coil for a relay); - under component similar enter a cross if relevant.
Box 2; 3 and 4	As per QPL entry; otherwise, an explanation of the changes must be supplied.
Box 5	Will show the ESCC Generic and Detail specifications, including issue number and revision letter, current at the time the tests reported were performed. If the specifications are different from those current on the date of the application, see Box 6.
Box 6	Will show the deviations from the Generic and Detail Specifications listed in Box 5, in particular deviations from testing. In case of deviations this must be listed in Box 15. In case the referenced specification in Box 5 have currently a different issue and/or revision indicate also whether the test data deviates or not from such current documents.
Box 7	Must reference the report(s) supplied in support of the application.
Box 8	Should provide the details of procurement to the full ESCC System, documentation of all of which should already have been delivered to the ESCC Executive under the terms of the relevant Generic Specification. An appropriate table has been drawn in this box.
Box 9	If the PID evolved after the Original Qualification or after the last Extension of Qualification, adequate details of such evolution shall be provided together with the reasons for the changes. Major changes shall be clearly marked.
Box 10	Identify the current PID issue status, date and actual date of verification. The date of verification of the current PID should be arranged as close as possible to the required date of extension.
Box 11	This box can be completed only after a physical visit to the plant to confirm that no unexplained changes occurred and that the practices, procedures, material, etc. used in manufacturing the components are as described in the PID. This survey shall be carried out in accordance with the requirements of ESCC Basic Specification No. 20200 and its findings shall be recorded.
Box 12	Provide details of, or reference to, any Destructive Physical Analysis (DPA) and Failure Analysis reports as well as any Nonconformance(s) (NCCS) occurred during the qualification validity period, stating if established corrective action have produced satisfactory results.
Box 13	Enter only the name of the Executive Member (i.e., CNES, DLR, ESTEC, etc.) and the signature of the responsible Executive Coordinator.
Box 14	To be used when there is a need to expand any of the boxes from 1 through 12. Identify box affected and reference the Box 14 in the relevant Box. Box 14 can be broken into 14a, 14b, etc. if several boxes have to be expanded.
Box 15	Fill in Table as requested.
Box 16	Any additional action deemed necessary by the Executive Member to bring the submitted data to a standard likely to be accepted by the ESCC Executive should be listed herein or the reason(s) to accept the noncompliance.
Box 17	All Executive Manager recommendations on the application itself, special conditions or restrictions, modifications of the QPL or QML entry, letters to the manufacturer, etc. shall be entered clearly in Box 19, signed by the representative for ESA, and dated.
Box 18	Fill in Table as requested.
Box 19	Confidential Details of PID changes including those of a confidential nature, shall be provided.
Box 20	State noncompliance with reference to specification(s) and paragraph(s). To simplify reference in Box 16 each nonconformance shall be sequentially numbered. If relevant state 'None'.
Box 21	Any additional action deemed necessary by the Executive Member to bring the submitted data to a standard likely to be accepted by the ESCC Executive should be listed herein or the reason(s) to accept the noncompliance.
Box 22	Additional Comments.